

Electronic Supplementary Information (ESI)

**Exploring Mn²⁺-Location-Dependent Red Emission from (Mn/Zn)-
Ga-Sn-S Supertetrahedral Nanocluster with Relatively Precise
Dopant Position**

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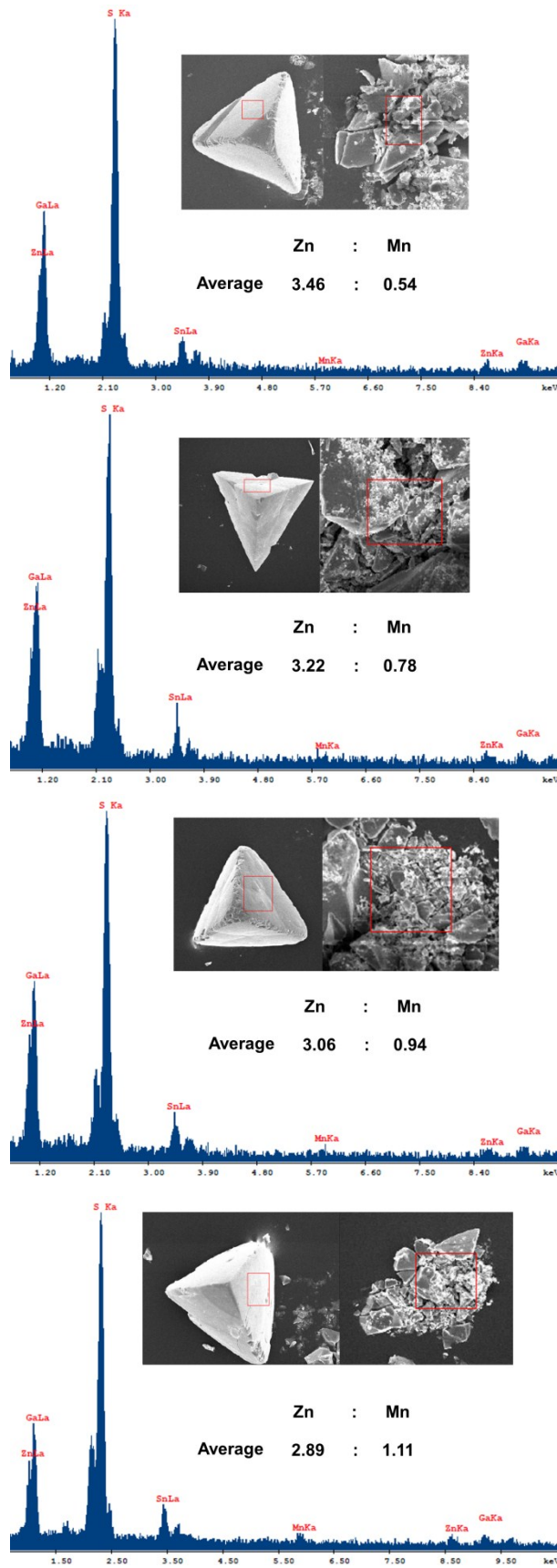


Fig. S1 EDS of four batches of Mn^{2+} -doped OCF-40-ZnGaSnS samples.

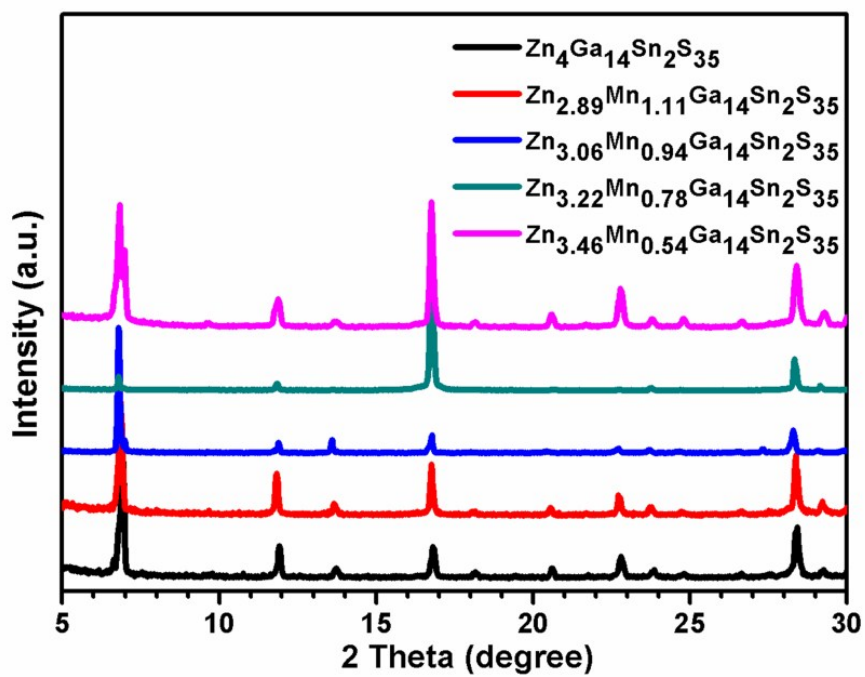


Fig. S2 PXRD patterns of Mn²⁺-doped samples at room temperature.

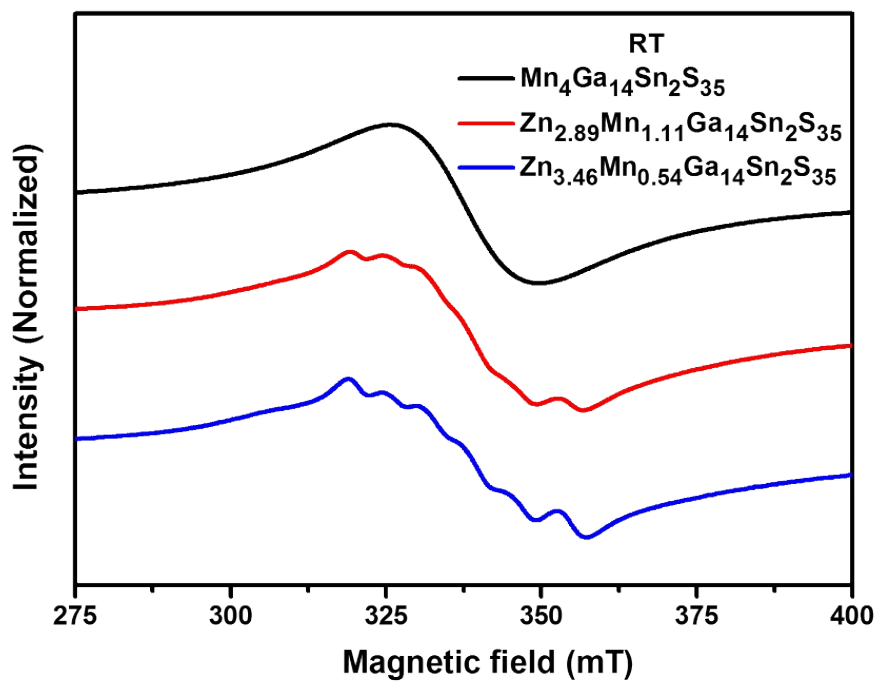


Fig. S3 EPR signals of OCF-40-MnGaSnS and Mn²⁺-doped samples under room temperature.

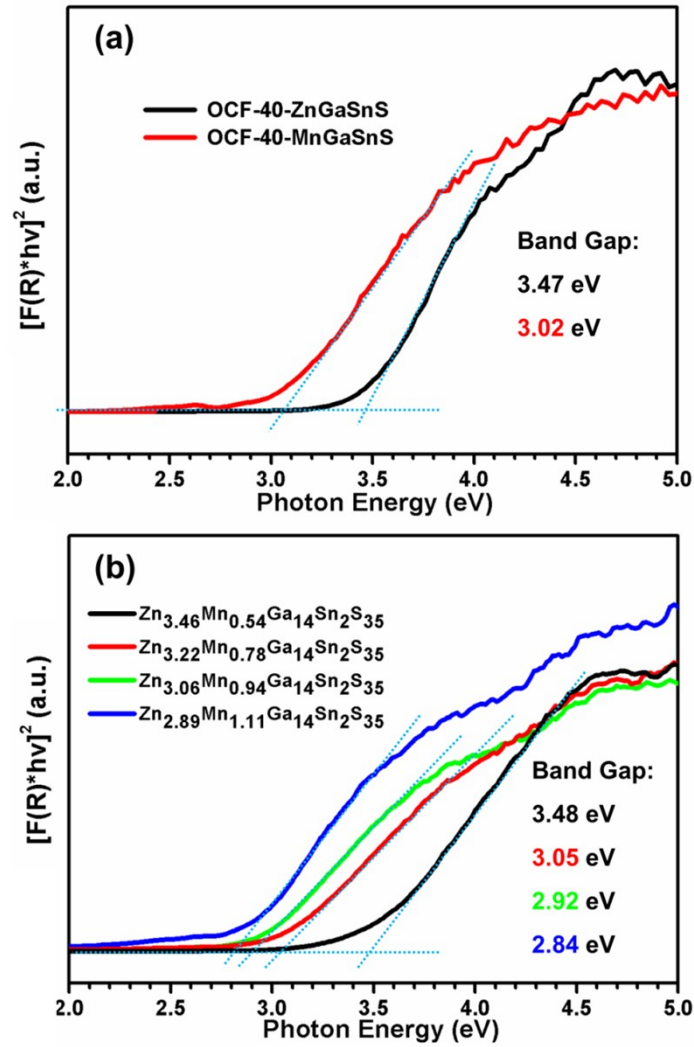


Fig. S4 Tauc plots of OCF-40-ZnGaSnS, OCF-40-MnGaSnS and Mn²⁺-doped samples.

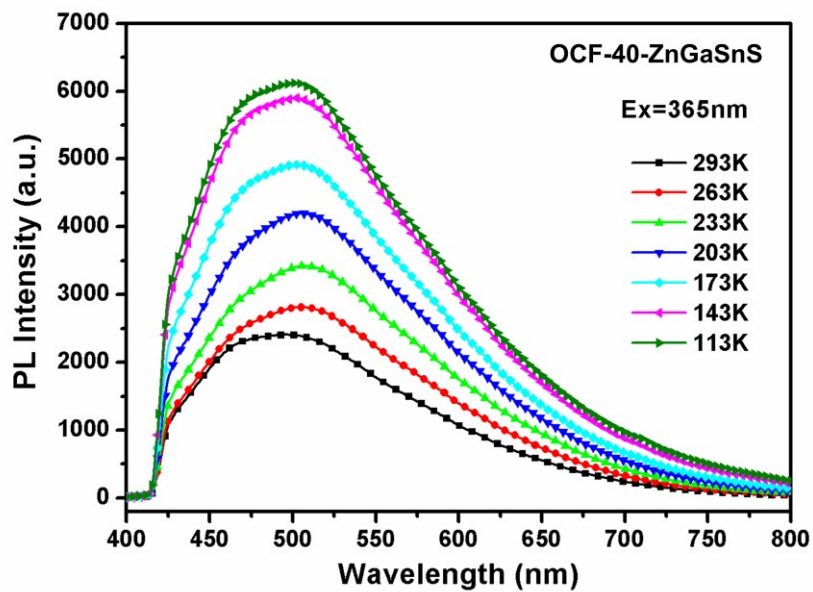


Fig. S5 Single-crystal PL of OCF-40-ZnGaSnS excited at 365 nm.

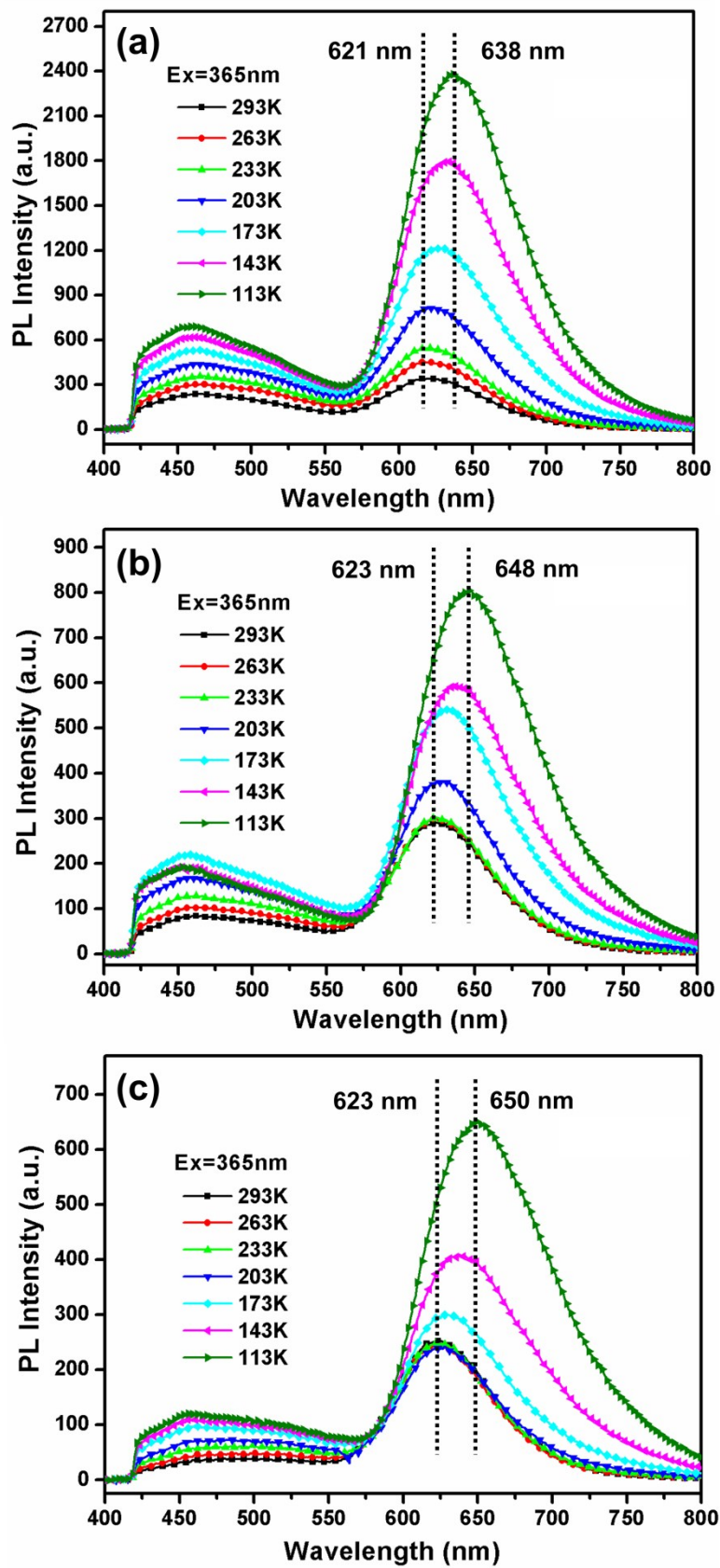


Fig. S6 Single-crystal PL spectra of Mn^{2+} -doped OCF-40-ZnGaSnS: (a) $\text{Zn}_{3.46}\text{Mn}_{0.54}\text{Ga}_{14}\text{Sn}_2\text{S}_{35}$; (b) $\text{Zn}_{3.22}\text{Mn}_{0.78}\text{Ga}_{14}\text{Sn}_2\text{S}_{35}$; (c) $\text{Zn}_{3.06}\text{Mn}_{0.94}\text{Ga}_{14}\text{Sn}_2\text{S}_{35}$.

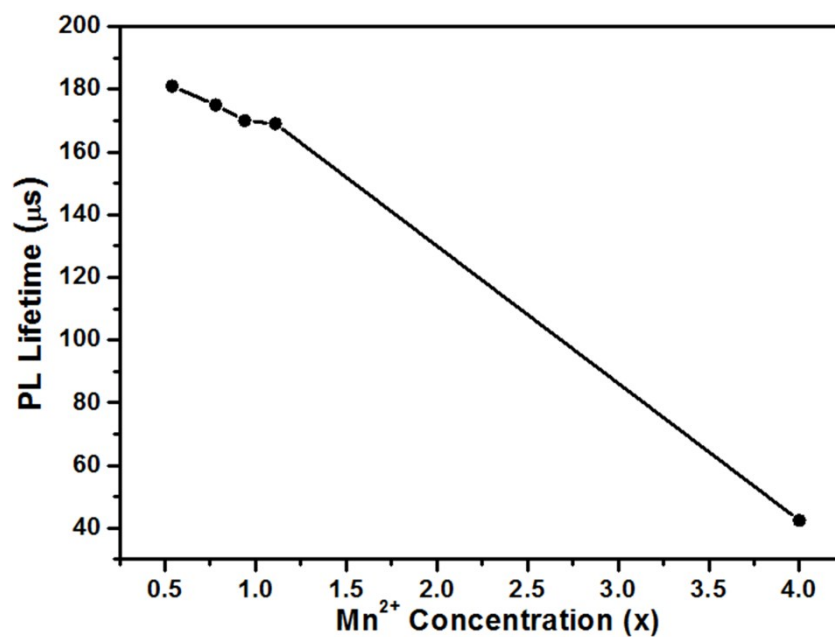


Fig. S7 Mn²⁺ concentration-dependent decay time of Mn²⁺-doped samples monitored at 642 nm upon the excitation of 474 nm at room temperature.

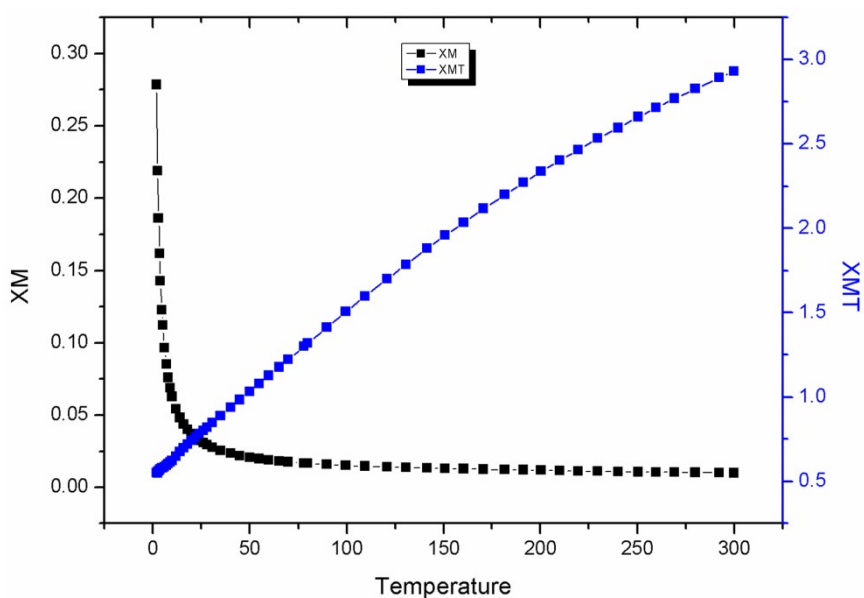


Fig. S8 The variable-temperature (2-300 K) magnetic susceptibility of the heavily-doped NC Mn₄Ga₄Sn₂S₃₅.

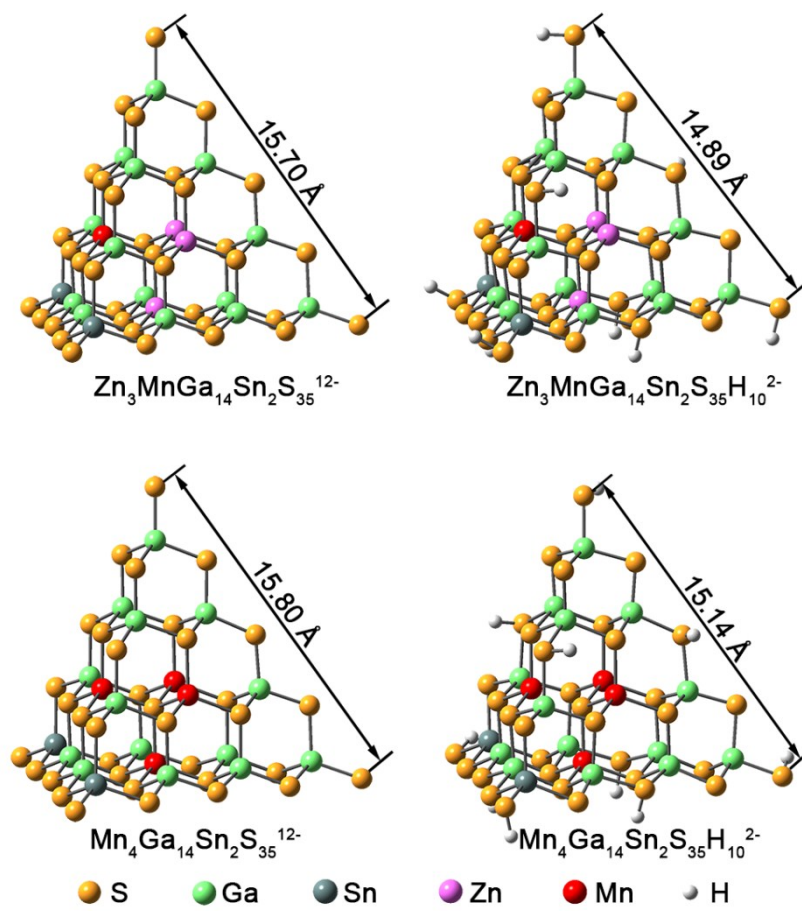


Fig. S9 Optimized structure of the bare and protonated NCs.

Table S1 The molar ratio of Zn : Mn in the Mn²⁺-doped samples.

| Zn(NO₃)₂·6H₂O (mg) | Mn(Ac)₂·4H₂O (mg) | Raw molar ratio of Zn : Mn | Actual Molar ratio of Zn : Mn | |
|--|--|---------------------------------------|--------------------------------------|----------------|
| | | | EDS | ICP-OES |
| 76.9 | 28 | 2.78 : 1.22 | 2.89 : 1.11 | 3.01 : 0.99 |
| 76.9 | 21 | 3.00 : 1.00 | 3.06 : 0.94 | 2.98 : 1.02 |
| 76.9 | 14 | 3.28 : 0.72 | 3.22 : 0.78 | / |
| 76.9 | 7 | 3.60 : 0.40 | 3.46 : 0.54 | / |

Table S2 PL Lifetime of OCF-40-MnGaSnS monitored at the emission wavelength of 642 nm under different temperature.

| Temp. | A ₁ (%) | τ_1 (s) | A ₂ (%) | τ_2 (s) | τ_{ave} (s) |
|-------|--------------------|--------------|--------------------|--------------|------------------|
| 296K | 45.01 | 1.064058E-05 | 54.99 | 6.849213E-05 | 4.24528E-05 |
| 273K | 35.35 | 9.669258E-06 | 64.65 | 7.679196E-05 | 5.26773E-05 |
| 243K | 28.95 | 1.072045E-05 | 71.05 | 9.039018E-05 | 6.73258E-05 |
| 213K | 21.01 | 1.235974E-05 | 78.99 | 1.122783E-04 | 7.39960E-05 |
| 183K | 15.26 | 9.668174E-06 | 84.74 | 1.304276E-04 | 1.11999E-04 |
| 153K | 12.21 | 1.26764E-05 | 87.79 | 1.622251E-04 | 1.43965E-04 |
| 123K | 15.89 | 1.417034E-05 | 84.11 | 1.76324E-04 | 1.50558E-04 |
| 93K | 26.75 | 2.898245E-05 | 73.25 | 1.95354E-04 | 1.50849E-04 |
| 63K | 26.65 | 6.311241E-05 | 73.35 | 2.240722E-04 | 1.81176E-04 |

Table S3 PL Lifetime of Mn²⁺-doped samples (Zn_{4-x}Mn_xGa₁₄Sn₂S₃₅) under room temperature.

| χ | A ₁ (%) | τ_1 | A ₂ (%) | τ_2 | τ_{ave} (s) |
|--------|--------------------|--------------|--------------------|--------------|------------------|
| 4 | 45.01 | 1.064058E-05 | 54.99 | 6.849213E-05 | 4.24528E-05 |
| 1.11 | 17.39 | 1.79328E-05 | 82.61 | 2.003149E-04 | 1.68599E-04 |
| 0.94 | 14.87 | 1.644032E-05 | 85.13 | 1.969501E-04 | 1.70108E-04 |
| 0.78 | 17.12 | 9.2786E-06 | 82.88 | 2.089991E-04 | 1.74807E-04 |
| 0.54 | 25.34 | 1.188928E-05 | 74.66 | 2.378971E-04 | 1.80627E-04 |

Full form of reference 27.

M. J. Frisch, G. W. Trucks, H. B. Schlegel, G. E. Scuseria, M. A. Robb, J. R. Cheeseman, G. Scalmani, V. Barone, B. Mennucci, G. A. Petersson, H. Nakatsuji, M. Caricato, X. Li, H. P. Hratchian, A. F. Izmaylov, J. Bloino, G. Zheng, J. L. Sonnenberg, M. Hada, M. Ehara, K. Toyota, R. Fukuda, J. Hasegawa, M. Ishida, T. Nakajima, Y. Honda, O. Kitao, H. Nakai, T. Vreven, J. J. A. Montgomery, J. E. Peralta, F. Ogliaro, M. Bearpark, J. J. Heyd, E. Brothers, K. N. Kudin, V. N. Staroverov, R. Kobayashi, J. Normand, K. Raghavachari, A. Rendell, J. C. Burant, S. S. Iyengar, J. Tomasi, M. Cossi, N. Rega, J. M. Millam, M. Klene, J. E. Knox, J. B. Cross, V. Bakken, C. Adamo, J. Jaramillo, R. Gomperts, R. E. Stratmann, O. Yazyev, A. J. Austin, R. Cammi, C. Pomelli, J. W. Ochterski, R. L. Martin, K. Morokuma, V. G. Zakrzewski, G. A. Voth, P. Salvador, J. J. Dannenberg, S. Dapprich, A. D. Daniels, O. Farkas, J. B. Foresman, J. V. Ortiz, J. Cioslowski and D. J. Fox, in Gaussian 09 Rev. D.01, Wallingford CT, Gaussian Inc. 2013.